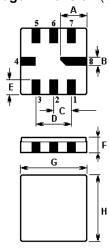


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The **ACTQ0016/916.5/QCC8C** is a two-port, 180° surface-acoustic-wave (**SAW**) resonator in a surface-mount ceramic **QCC8C** case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at **916.500** MHz.

1.Package Dimension (QCC8C)

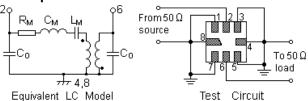


2.

Pin	Configuration			
2	Terminal1			
6	Terminal2			
4,8	Case Ground			
1,3,5,7	Empty			

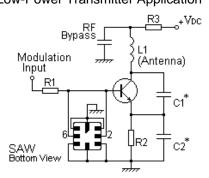
Sign	Data (unit: mm)	Sign Data (unit: mm)		
Α	2.08	Е	1.2	
В	0.6	F	1.35	
С	1.27	G	5.0	
D	2.54	Н	5.0	

3. Equivalent LC Model and Test Circuit

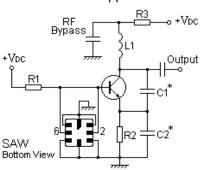


4. Typical Application Circuits

1) Low-Power Transmitter Application



2) Local Oscillator Application



Issue: 1 C1

Date: SEPT 04

In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

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For quotations or further information please contact us at:

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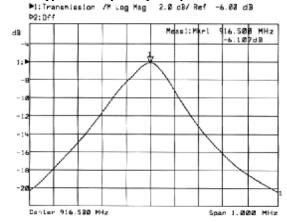
+44 118 979 1238 Tel: Fax: +44 118 979 1283

Issue: 1 C1

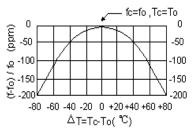
Date: SEPT 04

Email: info@actcrystals.com

5. Typical Frequency Response



6.Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include LC component temperature characteristics.

7.Performance

7-1.Maximum Ratings

Rating	Value	Units	
CW RF Power Dissipation	10	dBm	
DC Voltage Between Terminals	±30V	VDC	
Case Temperature	-40 to +85	°C	
Soldering Temperature	+250	°C	

7-2. Electronic Characteristics

7 Z.Eloctorio Orianocinato									
	Characteristics	Sym	Minimum	Typical	Maximum	Units			
Centre Frequency (+25 °C)	Absolute Frequency	f _C	916.350		916.650	MHz			
	Tolerance from 916.500 MHz	Δf_{C}		±150		kHz			
Insertion Loss		IL		6.5	9.0	dB			
Quality Factor	Unloaded Q	Q _U		6,650					
	50 Ω Loaded Q	Q_L		3,500					
Temperature Stability	Turnover Temperature	T ₀	25		55	°C			
	Turnover Frequency	f ₀		fc		kHz			
	Frequency Temperature Coefficient	FTC		0.03		ppm/°C 2			
Frequency Aging - Absolute Value during the First Year		f _A		≤10		ppm/yr			
DC Insulation Resistance Between Any Two Terminals			1.0			ΜΩ			
RF Equivalent RLC Model	Motional Resistance	R_{M}		111.35	182	Ω			
	Motional Inductance	L _M		128.5222		μН			
	Motional Capacitance	См		0.2349		fF			
	Shunt Static Capacitance	C ₀	2.30	2.55	2.80	pF			

i CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

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- 1. The frequency f_C is the frequency of minimum IL with the resonator in the specified test fixture in a 50 Ω test system with VSWR \leq 1.2:1.
- 2. Unless noted otherwise, case temperature $T_C = +25^{\circ}C \pm 2^{\circ}C$.
- Frequency aging is the change in f_C with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- 4. Turnover temperature, T_0 , is the temperature of maximum (or turnover) frequency, f_0 . The nominal frequency at any case temperature, T_0 , may be calculated from: $f = f_0 [1 FTC (T_0 T_0)^2]$.
- 5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C₀ is the measured static (non-motional) capacitance between input terminal and ground or output terminal and ground. The measurement includes case parasitic capacitance.
- 6. Derived mathematically from one or more of the following directly measured parameters: f c, IL, 3 dB bandwidth, fc versus Tc, and Co.
- The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- 8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- 9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

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